

## SIPMOS® Power-Transistor

### Feature

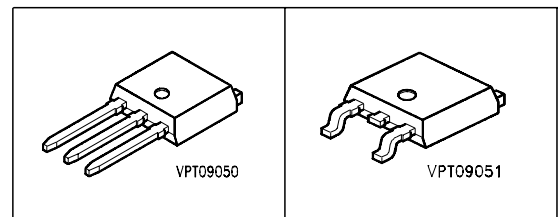
- P-Channel
- Enhancement mode
- 175°C operating temperature
- Avalanche rated
- dv/dt rated

### Product Summary

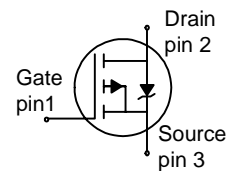
$V_{DS}$	-60	V
$R_{DS(on)}$	0.075	$\Omega$
$I_D$	-30	A

P-TO251

P-TO252



Type	Package	Ordering Code
SPD30P06P	P-TO252	Q67042-S4018
SPU30P06P	P-TO251	Q67042-S4019



### Maximum Ratings, at $T_j = 25\text{ }^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current	$I_D$	-30	A
$T_C=25\text{ }^\circ\text{C}$		-30	
$T_C=100\text{ }^\circ\text{C}$		-21.5	
Pulsed drain current	$I_{D\text{ puls}}$	-120	
$T_C=25\text{ }^\circ\text{C}$			
Avalanche energy, single pulse	$E_{AS}$	250	mJ
$I_D=-30\text{ A}$ , $V_{DD}=-25\text{ V}$ , $R_{GS}=25\text{ }\Omega$			
Avalanche energy, periodic limited by $T_{jmax}$	$E_{AR}$	12.5	
Reverse diode dv/dt	dv/dt	-6	kV/ $\mu\text{s}$
$I_S=-30\text{ A}$ , $V_{DS}=-48\text{ V}$ , $di/dt=-200\text{ A}/\mu\text{s}$ , $T_{jmax}=175\text{ }^\circ\text{C}$			
Gate source voltage	$V_{GS}$	$\pm 20$	V
Power dissipation	$P_{tot}$	125	W
$T_C=25\text{ }^\circ\text{C}$			
Operating and storage temperature	$T_j, T_{stg}$	-55... +175	$^\circ\text{C}$
IEC climatic category; DIN IEC 68-1		55/175/56	

**Thermal Characteristics**

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Characteristics</b>					
Thermal resistance, junction - case	$R_{thJC}$	-	-	1.2	K/W
Thermal resistance, junction - ambient, leaded	$R_{thJA}$	-	-	100	
SMD version, device on PCB:	$R_{thJA}$				
@ min. footprint		-	-	75	
@ 6 cm <sup>2</sup> cooling area <sup>1)</sup>		-	-	50	

**Electrical Characteristics**, at  $T_j = 25\text{ °C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>Static Characteristics</b>					
Drain-source breakdown voltage $V_{GS}=0, I_D=-250\mu A$	$V_{(BR)DSS}$	-60	-	-	V
Gate threshold voltage, $V_{GS} = V_{DS}$ $I_D=-1.7mA$	$V_{GS(th)}$	-2.1	-3	-4	
Zero gate voltage drain current $V_{DS}=-60V, V_{GS}=0, T_j=25\text{ °C}$ $V_{DS}=-60V, V_{GS}=0, T_j=150\text{ °C}$	$I_{DSS}$	-	-0.1 -10	-1 -100	$\mu A$
Gate-source leakage current $V_{GS}=-20V, V_{DS}=0$	$I_{GSS}$	-	-10	-100	
Drain-source on-state resistance $V_{GS}=-10V, I_D=-21.5A$	$R_{DS(on)}$	-	0.066	0.075	$\Omega$

<sup>1)</sup>Device on 40mm\*40mm\*1.5mm epoxy PCB FR4 with 6cm<sup>2</sup> (one layer, 70  $\mu m$  thick) copper area for drain connection. PCB is vertical without blown air.

Electrical Characteristics, at  $T_j = 25\text{ }^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	

**Dynamic Characteristics**

Transconductance	$g_{fs}$	$ V_{DS}  \geq 2 *  I_D  * R_{DS(on)max}$ , $I_D = -21.5\text{A}$	5.2	10.4	-	S
Input capacitance	$C_{iss}$	$V_{GS} = 0, V_{DS} = -25\text{V}$ , $f = 1\text{MHz}$	-	1228	1535	pF
Output capacitance	$C_{oss}$		-	387	484	
Reverse transfer capacitance	$C_{rss}$		-	142	177	
Turn-on delay time	$t_{d(on)}$	$V_{DD} = -30\text{V}, V_{GS} = -10\text{V}$ , $I_D = -21.5\text{A}, R_G = 3.3\Omega$	-	8.7	13	ns
Rise time	$t_r$		-	25.2	37.8	
Turn-off delay time	$t_{d(off)}$		-	27.4	41.1	
Fall time	$t_f$		-	14.6	21.9	

**Gate Charge Characteristics**

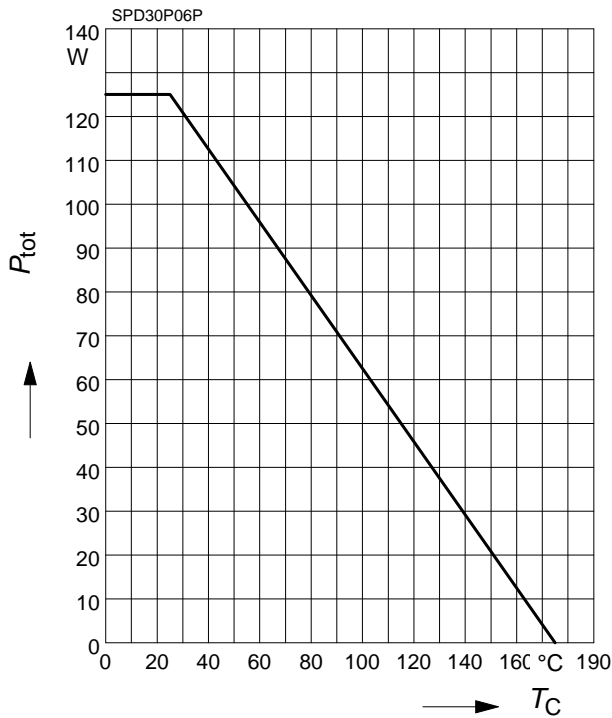
Gate to source charge	$Q_{gs}$	$V_{DD} = -48\text{V}, I_D = -30\text{A}$	-	-3.7	-5.6	nC
Gate to drain charge	$Q_{gd}$		-	-13.8	-20.7	
Gate charge total	$Q_g$	$V_{DD} = -48\text{V}, I_D = -30\text{A}$ , $V_{GS} = 0 \text{ to } -10\text{V}$	-	-32	-48	
Gate plateau voltage	$V_{(plateau)}$	$V_{DD} = -48\text{V}, I_D = -30\text{A}$	-	-5.2	-	V

**Reverse Diode**

Inverse diode continuous forward current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$	-	-	-30	A
Inv. diode direct current, pulsed	$I_{SM}$		-	-	-120	
Inverse diode forward voltage	$V_{SD}$	$V_{GS} = 0,  I_F  =  I_S $	-	-1.3	-1.7	V
Reverse recovery time	$t_{rr}$	$V_R = -30\text{V},  I_F  =  I_S $ , $di_F/dt = 100\text{A}/\mu\text{s}$	-	64.6	97	ns
Reverse recovery charge	$Q_{rr}$		-	153	230	

### 1 Power dissipation

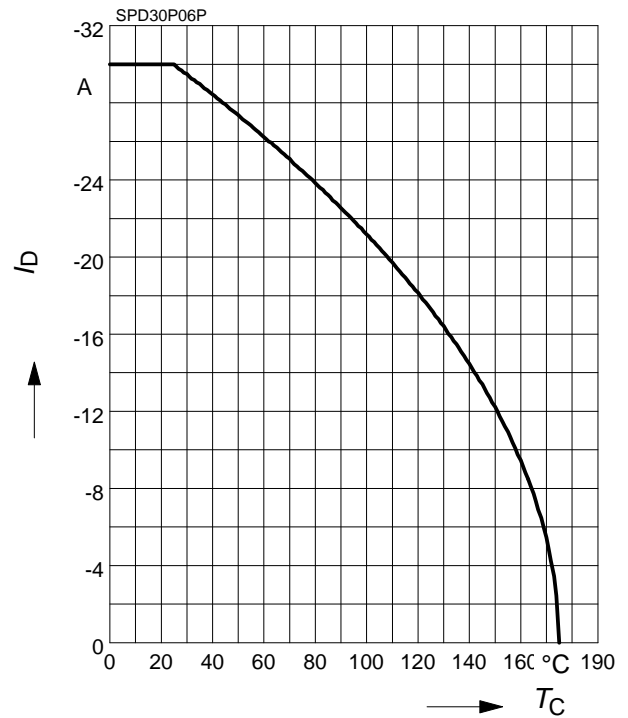
$$P_{tot} = f(T_C)$$



### 2 Drain current

$$I_D = f(T_C)$$

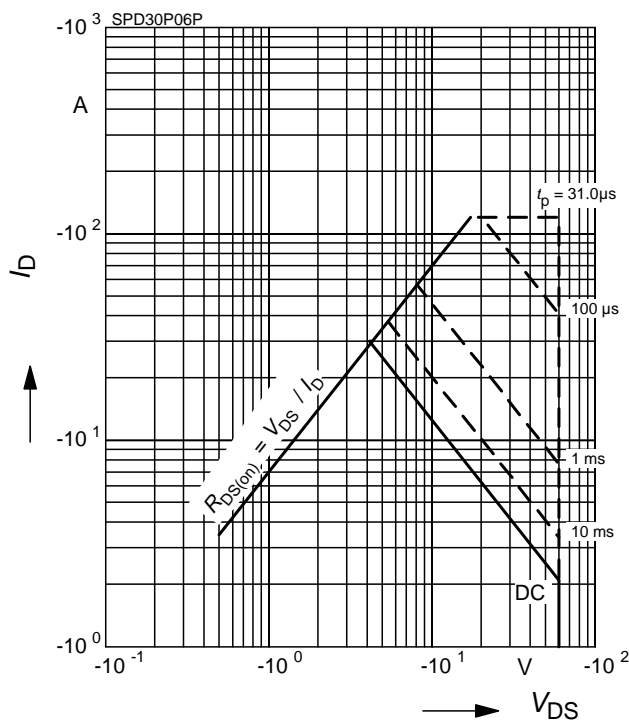
parameter:  $|V_{GS}| \geq 10 \text{ V}$



### 3 Safe operating area

$$I_D = f(V_{DS})$$

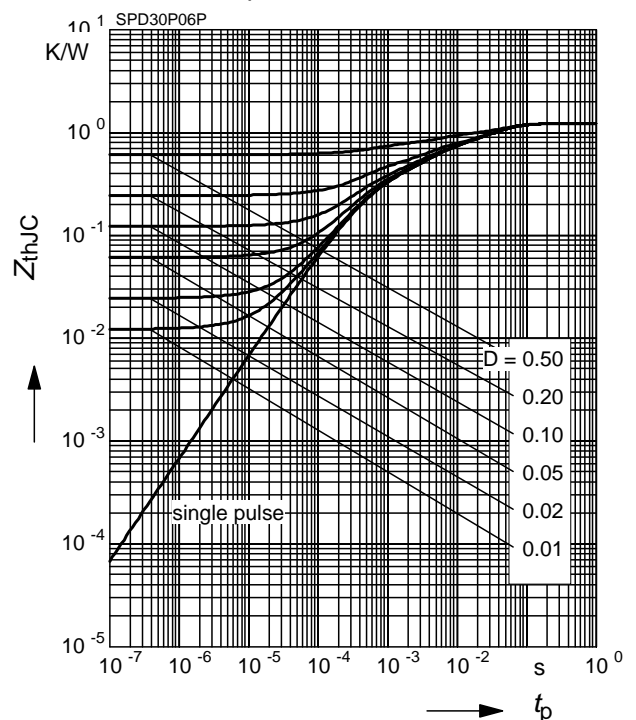
parameter:  $D = 0$ ,  $T_C = 25 \text{ °C}$



### 4 Max. transient thermal impedance

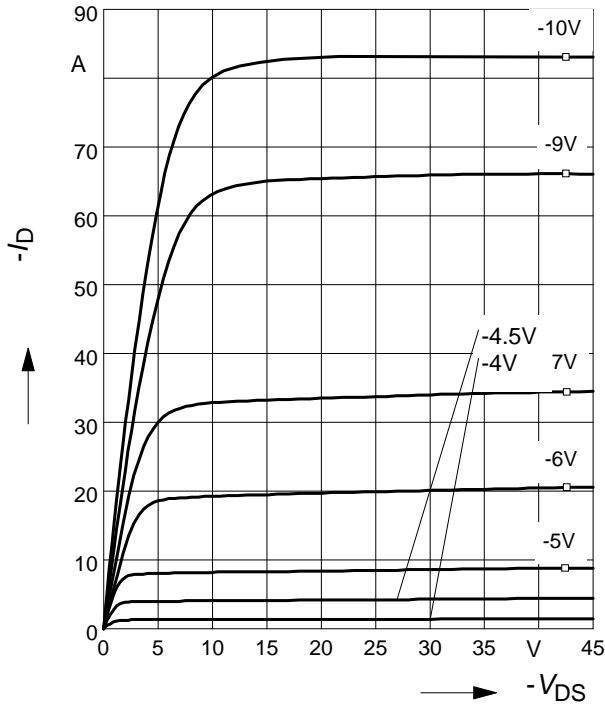
$$Z_{thJC} = f(t_p)$$

parameter:  $D = t_p/T$



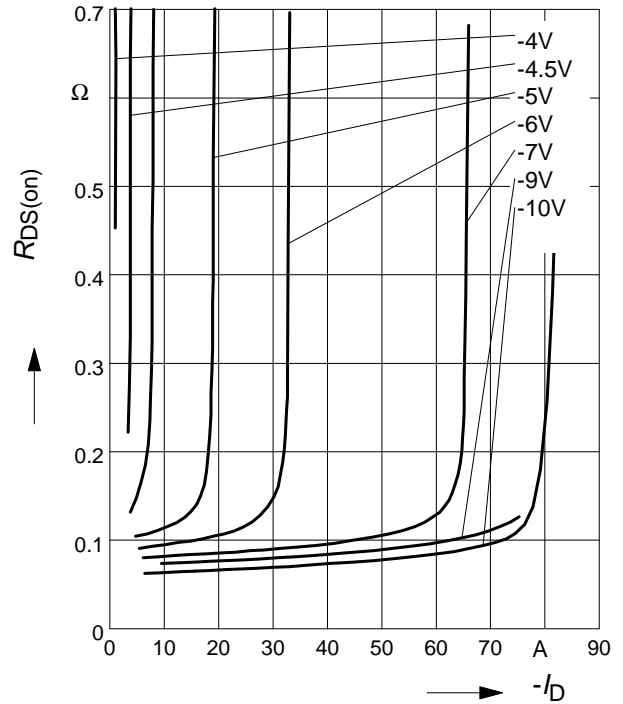
**5 Typ. output characteristic**

$I_D = f(V_{DS})$   
parameter:  $T_j = 25^\circ\text{C}$



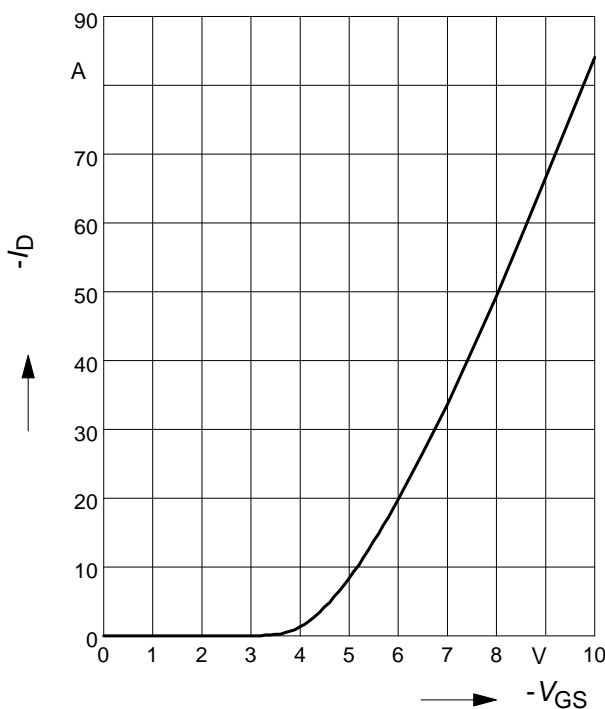
**6 Typ. drain-source on resistance**

$R_{DS(on)} = f(I_D)$   
parameter:  $V_{GS}; T_j = 25^\circ\text{C}$



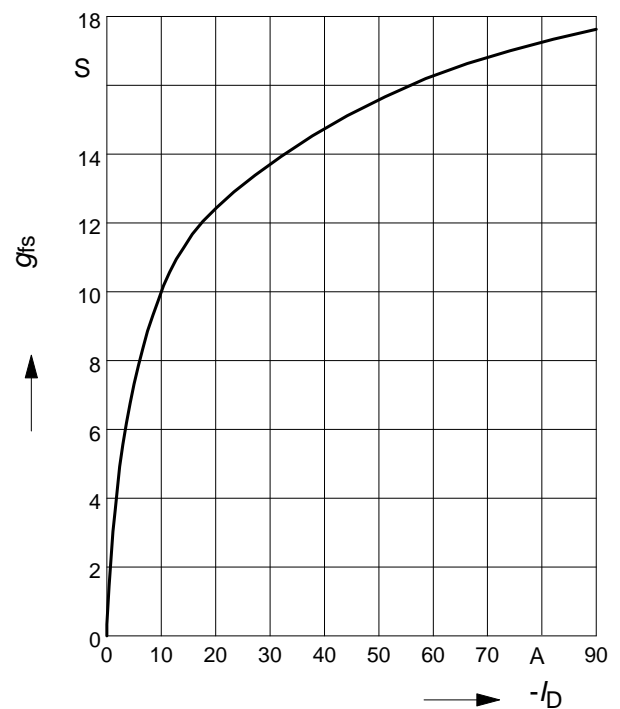
**7 Typ. transfer characteristics**

$I_D = f(V_{GS}); |V_{DS}| \geq 2 \times |I_D| \times R_{DS(on)max}$   
parameter:  $T_j = 25^\circ\text{C}$



**8 Typ. forward transconductance**

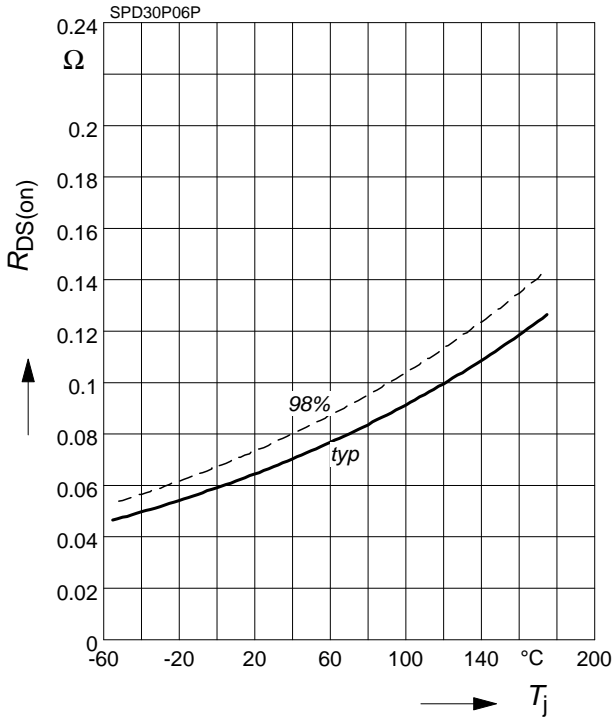
$g_{fs} = f(I_D)$   
parameter:  $T_j = 25^\circ\text{C}$



**9 Drain-source on-state resistance**

$$R_{DS(on)} = f(T_j)$$

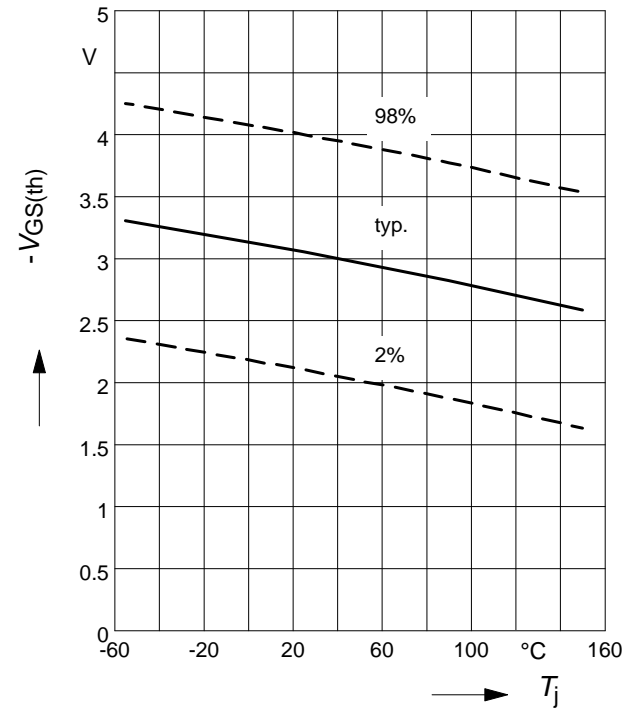
parameter :  $I_D = -21.5 \text{ A}$ ,  $V_{GS} = -10 \text{ V}$



**10 Typ. gate threshold voltage**

$$V_{GS(th)} = f(T_j)$$

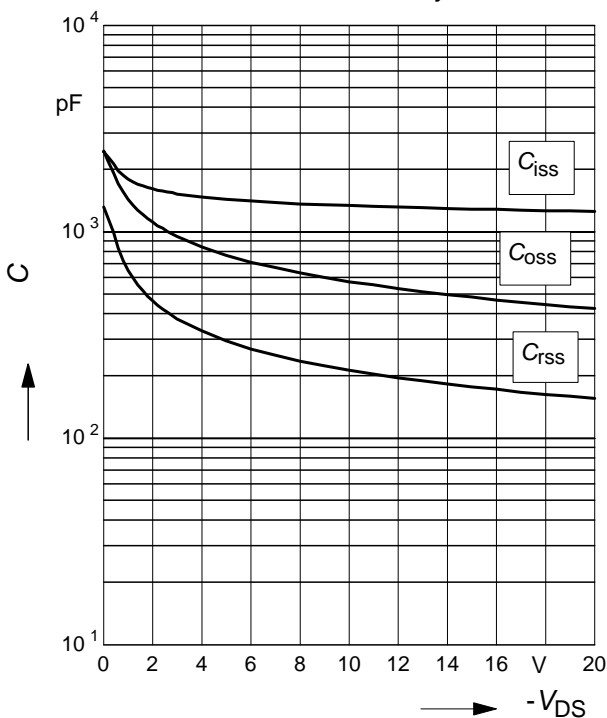
parameter:  $V_{GS} = V_{DS}$



**11 Typ. capacitances**

$$C = f(V_{DS})$$

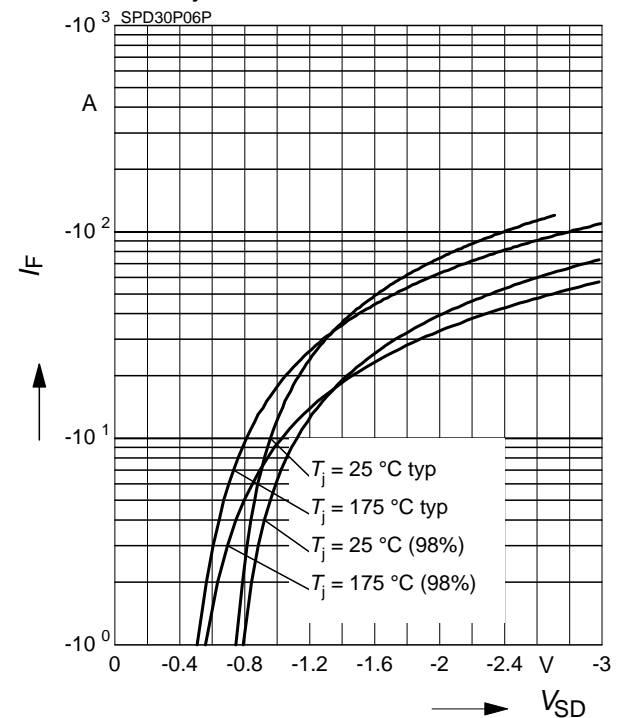
parameter:  $V_{GS}=0$ ,  $f=1 \text{ MHz}$ ;  $T_j = 25 \text{ }^\circ\text{C}$



**12 Forward character. of reverse diode**

$$I_F = f(V_{SD})$$

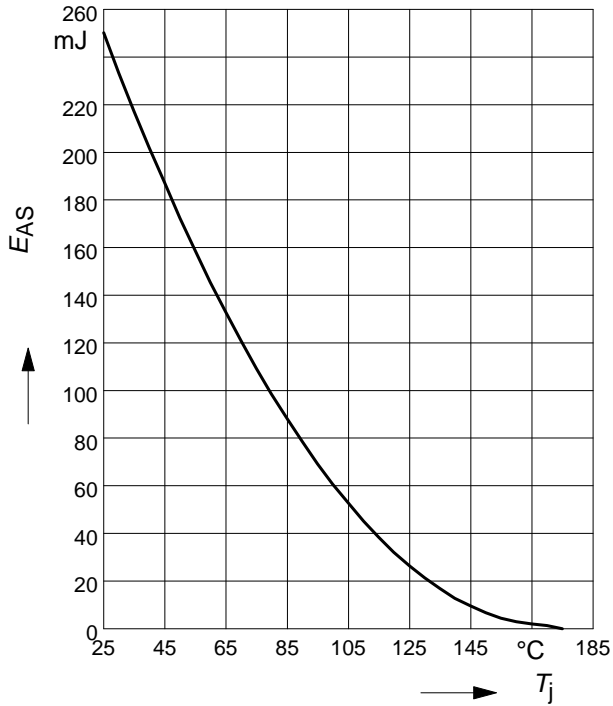
parameter:  $T_j$ ,  $t_p = 80 \mu\text{s}$



**13 Typ. avalanche energy**

$$E_{AS} = f(T_j)$$

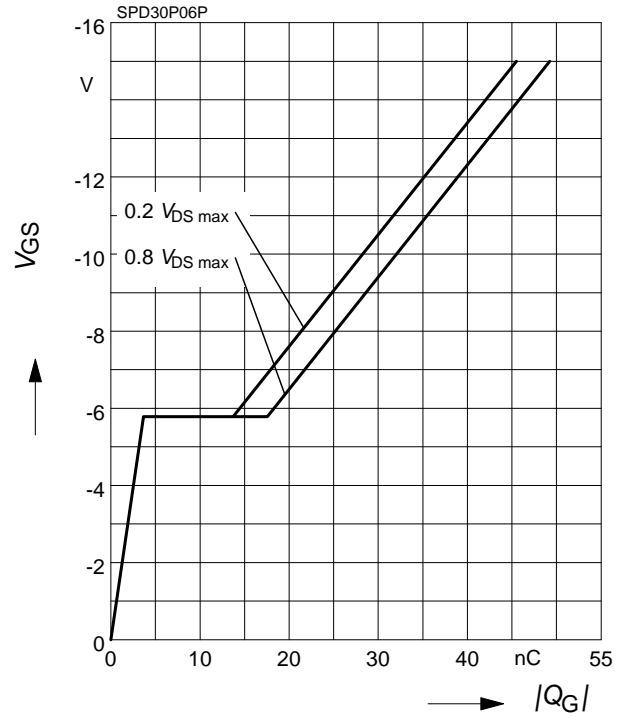
par.:  $I_D = -30\text{ A}$  ,  $V_{DD} = -25\text{ V}$  ,  $R_{GS} = 25\ \Omega$



**14 Typ. gate charge**

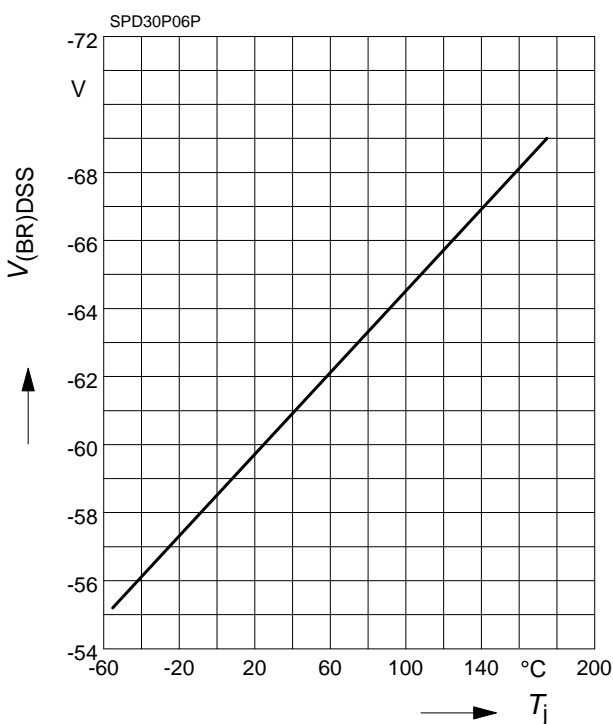
$$V_{GS} = f(Q_G), \text{ parameter: } V_{DS}; T_j = 25\text{ °C}$$

$I_D = -30\text{ A}$  pulsed;



**15 Drain-source breakdown voltage**

$$V_{(BR)DSS} = f(T_j)$$



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